

**Search Notes**

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Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

SHIMIZU ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	405,406 410,411	6/29/2005	TT
438	216,261	6/29/2005	TT
438	591	6/29/2005	TT
Above	updated	10/30/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference Search History Printout	10/30/2005	TT